

**Search Notes**

Application/Control No.

10/625,164

Examiner

Jeffrey G. Hoekstra

Applicant(s)/Patent under  
Reexamination

REED ET AL.

Art Unit

3736

**SEARCHED**

Class	Subclass	Date	Examiner
600	562	10/17/2005	JGH
600	563	10/17/2005	JGH
600	572	10/17/2005	JGH
600	569	10/17/2005	JGH
435	226	10/18/2005	JGH
435	6	10/18/2005	JGH
435	309.1	10/18/2005	JGH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR